## WE CLAIM:

- 1. A process of making a magnetoresistive
- 2 memory device comprising:
- 3 making a mask having stepped bit ends;
- 4 using the mask to make a magnetic storage layer
- 5 having tapered bit ends;
- 6 using the mask to make a magnetic sense layer
- 7 having tapered bit ends; and,
- 8 using the mask to make a non-magnetic layer
- 9 between the magnetic sense layer and the magnetic storage
- 10 layer, and wherein the non-magnetic layer has tapered bit
- 11 ends.
- 1 2. The process of claim 1 wherein the
- 2 magnetic storage layer comprises one or more magnetic
- 3 storage films.
- 1 3. The process of claim 1 wherein the
- 2 magnetic storage layer comprises first and second
- 3 magnetic storage films, wherein the first magnetic
- 4 storage film comprises NiFe, and wherein the second
- 5 magnetic storage film comprises CoFe.

- 1 4. The process of claim 1 wherein the
- 2 magnetic sense layer comprises one or more magnetic sense
- 3 films.
- 1 5. The process of claim 1 wherein the
- 2 magnetic sense layer comprises first and second magnetic
- 3 sense films, wherein the first magnetic sense film
- 4 comprises NiFe, and wherein the second magnetic sense
- 5 film comprises CoFe.
- 1 6. The process of claim 1 wherein the
- 2 magnetic storage layer comprises one or more magnetic
- 3 storage films, and wherein the magnetic sense layer
- 4 comprises one or more magnetic sense films.
- 1 7. The process of claim 1 wherein the
- 2 magnetic storage layer comprises first and second
- 3 magnetic storage films, wherein the magnetic sense layer
- 4 comprises first and second magnetic sense films, wherein
- 5 the first magnetic storage film comprises NiFe, wherein
- 6 the second magnetic storage film comprises CoFe, wherein
- 7 the first magnetic sense film comprises NiFe, and wherein
- 8 the second magnetic sense film comprises CoFe.

- 1 8. The process of claim 1 wherein the
- 2 magnetic sense film comprises a ferromagnetic sense film.
- 1 9. The process of claim 1 wherein the
- 2 magnetic storage film comprises a ferromagnetic storage
- 3 film.
- 1 10. The process of claim 9 wherein the
- 2 magnetic sense film comprises a ferromagnetic sense film.
- 1 11. The process of claim 1 wherein the using
- 2 of the mask to make a magnetic storage layer having
- 3 tapered bit ends, the using of the mask to make a
- 4 magnetic sense layer having tapered bit ends, and the
- 5 using of the mask to make a non-magnetic layer between
- 6 the magnetic sense layer and the magnetic storage layer
- 7 are performed in a single lithographic patterning step.
- 1 12. The process of claim 1 wherein the using
- 2 of the mask to make a magnetic storage layer having
- 3 tapered bit ends, the using of the mask to make a
- 4 magnetic sense layer having tapered bit ends, and the
- 5 using of the mask to make a non-magnetic layer between

- 6 the magnetic sense layer and the magnetic storage layer
- 7 are performed as separate lithographic patterning steps.
- 1 13. A magnetoresistive device made by the
- 2 process of claim 1.
- 1 14. A process of making a magnetoresistive
- 2 memory device comprising:
- 3 laying out a mask layout in grids having a
- 4 central grid forming a central section and outer grids
- 5 forming bit end sections, and wherein the grids of the
- 6 bit end sections are rectangles;
- 7 making a mask by use of the mask layout,
- 8 wherein the mask has stepped bit ends;
- 9 using the mask to make a magnetic storage layer
- 10 having tapered bit ends;
- 11 using the mask to make a magnetic sense layer
- 12 having tapered bit ends; and,
- using the mask to make a non-magnetic layer
- 14 between the magnetic sense layer and the magnetic storage
- 15 layer, wherein the non-magnetic layer has tapered bit
- 16 ends.

- 1 15. The process of claim 14 wherein the
- 2 magnetic storage layer comprises one or more magnetic
- 3 storage films.
- 1 16. The process of claim 14 wherein the
- 2 magnetic storage layer comprises first and second
- 3 magnetic storage films, wherein the first magnetic
- 4 storage film comprises NiFe, and wherein the second
- 5 magnetic storage film comprises CoFe.
- 1 17. The process of claim 14 wherein the
- 2 magnetic sense layer comprises one or more magnetic sense
- 3 films.
- 1 18. The process of claim 14 wherein the
- 2 magnetic sense layer comprises first and second magnetic
- 3 sense films, wherein the first magnetic sense film
- 4 comprises NiFe, and wherein the second magnetic sense
- 5 film comprises CoFe.
- 1 19. The process of claim 14 wherein the
- 2 magnetic storage layer comprises one or more magnetic
- 3 storage films, and wherein the magnetic sense layer
- 4 comprises one or more magnetic sense films.

- 1 20. The process of claim 14 wherein the
- 2 magnetic storage layer comprises first and second
- 3 magnetic storage films, wherein the magnetic sense layer
- 4 comprises first and second magnetic sense films, wherein
- 5 the first magnetic storage film comprises NiFe, wherein
- 6 the second magnetic storage film comprises CoFe, wherein
- 7 the first magnetic sense film comprises NiFe, and wherein
- 8 the second magnetic sense film comprises CoFe.
- 1 21. The process of claim 14 wherein the
- 2 magnetic sense film comprises a ferromagnetic sense film.
- 1 22. The process of claim 14 wherein the
- 2 magnetic storage film comprises a ferromagnetic storage
- 3 film.
- 1 23. The process of claim 22 wherein the
- 2 magnetic sense film comprises a ferromagnetic sense film.
- 1 24. The process of claim 14 wherein the using
- 2 of the mask to make a magnetic storage layer having
- 3 tapered bit ends, the using of the mask to make a
- 4 magnetic sense layer having tapered bit ends, and the

- 5 using of the mask to make a non-magnetic layer between
- 6 the magnetic sense layer and the magnetic storage layer
- 7 are performed in a single lithographic patterning step.
- 1 25. The process of claim 14 wherein the using
- 2 of the mask to make a magnetic storage layer having
- 3 tapered bit ends, the using of the mask to make a
- 4 magnetic sense layer having tapered bit ends, and the
- 5 using of the mask to make a non-magnetic layer between
- 6 the magnetic sense layer and the magnetic storage layer
- 7 are performed as separate lithographic patterning steps.
- 1 26. A magnetoresistive device made by the
- 2 process of claim 14.